

Attorney Docket No. 1293.1144/MDS/JGM

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Pate	nt Ap	plicati	on of:)	#8				
Tae-kyun	g KIN	M, et a	I.))))	Group Art Unit: To be assigned Examiner: To be assigned				
Application	on No).:								
Filed: Oc	tober	30, 20	000							
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			INFORMATIC	ON DISCI	LOSUI	RE STATEMENT ECEIVED				
Assistant Washingt			ner for Patents			MAR 2 2 2004				
Sir:	on, 2	2				Technology Center 2600				
certain in patent app	forma	ation w ion. It	hich the Examiner m	ay consider Examiner n	materia	7 CFR §1.56, there is hereby provided I to the examination of the subject U.S. information of record if it is deemed				
1. Encl	osure	s acco	mpanying this Inform	nation Disclo	osure St	atement are:				
	1a.	[X]	Form PTO-1449.			·				
•	1b.	[X]	Copies of IDS citations.							
	1c.	[]	An English language copy of search report(s) from a counterpart foreign application a PCT International Search Report.							
	1d.	[]	English language translation (complete or relevant portion(s)) attached to each non-English language publication.							
	1e.	[]	Explanations of Rel providing a concise	evancy of R explanation	References (ATTACHMENT 1(e), hereto) for on of each non-English publication.					
	1f.	[]	List of Copending A	Applications	(ATTA)	CHMENT 1(f), hereto).				
2. [X]	In a	ccorda	nce with 37 CFR §1.	98, a concis	se explai	nation of what is presently understood to be				

(Check appropriate Items 2a, 2b, 2c and/or 2d)

the relevance of each non-English language publication is:

S&H IDS Form-New USPA filing (1/00) e1992, 1998 Staas & Halsey

- 2a. [] satisfied because all non-English language publications were cited on the enclosed English language copy of the PCT International Search Report or the search report from a counterpart foreign application indicating the degree of relevance found by the foreign office. (See U.S. Patent & Trademark Office's authorization in the Federal Register, Vol. 57, No. 12, January 17, 1992, at page 2031 (Reply to Comment 68).)
- 2b. [X] set forth in the application.
- 2c. [] satisfied because an English language translation (complete or relevant portion(s)) is attached to each non-English language publication.
- 2d. [] enclosed as Attachment 1(e), hereto.
- 3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h).

Respectfully submitted,

STAAS & HALSEY LLP

Dated: (U) 50/00

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Michael D. Stein

Registration No. 37,240

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MAR 1 9 2004 PATENT AND TRADEMARK OFFI LIST OF REFERENCES CITED BY APPLICANT						FIRST NAMED INVENTOR					
LIST	Tae-kyung KIM, et al.										
	FILING DATE	GROU	GROUP ART UNIT								
	October 30, 2	To l	To be assigned								
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance

and not considered. Include copy of this form with next communication to applicant.